# 10-Bit, 40/65/80/105 MSPS 3 V Dual Analog-to-Digital Converter 

## FEATURES

- Dual 10-bit, 40 MSPS, 65 MSPS, 80 MSPS, and 105 MSPS ADC
- Low power: 275 mW at 105 MSPS per channel
- On-chip reference and track-and-hold
- 300 MHz analog bandwidth each channel
- SNR $=57 \mathrm{~dB}$ @ 41 MHz , Encode = 80 MSPS
- 1 V p-p or 2 V p-p analog input range each channel
- 3.0 V single-supply operation ( 2.7 V to 3.6 V )
- Power-down mode for single-channel operation
- Twos complement or offset binary output mode
- Output data alignment mode
- Pin compatible with the 8-bit AD9288
- -75 dBc crosstalk between channels


## APPLICATIONS

- Battery-powered instruments
- Hand-held scopemeters
- Low cost digital oscilloscopes
- I and Q communications
- Ultrasound equipment


## GENERAL DESCRIPTION

The AD9218 is a dual 10 -bit monolithic sampling analog-to-digital converter with on-chip track-and-hold circuits. The product is low cost, low power, and is small and easy to use. The AD9218 operates at a 105 MSPS conversion rate with outstanding dynamic performance over its full operating range. Each channel can be operated independently.
The ADC requires only a single $3.0 \mathrm{~V}(2.7 \mathrm{~V}$ to 3.6 V ) power supply and a clock for full operation. No external reference or driver components are required for many applications. The digital outputs are TTL/CMOS compatible and a separate output power supply pin supports interfacing with 3.3 V or 2.5 V logic.

The clock input is TTL/CMOS compatible and the 10-bit digital outputs can be operated from $3.0 \mathrm{~V}(2.5 \mathrm{~V}$ to 3.6 V$)$ supplies. Userselectable options offer a combination of power-down modes, digital data formats, and digital data timing schemes. In power-down mode, the digital outputs are driven to a high impedance state.

## FUNCTIONAL BLOCK DIAGRAM



Figure 1.

## PRODUCT HIGHLIGHTS

1. Low Power. Only 275 mW power dissipation per channel at 105 MSPS. Other speed grades proportionally scaled down while maintaining high ac performance.
2. Pin Compatibility Upgrade. Allows easy migration from 8 -bit to 10-bit devices. Pin compatible with the 8 -bit AD9288 dual ADC.
3. Easy to Use. On-chip reference and user controls provide flexibility in system design.
4. High Performance. Maintains 54 dB SNR at 105 MSPS with a Nyquist input.
5. Channel Crosstalk. Very low at -75 dBc .
6. Fabricated on an Advanced CMOS Process. Available in a 48lead low profile quad flat package ( $7 \mathrm{~mm} \times 7 \mathrm{~mm}$ LQFP) specified over the industrial temperature range $\left(-40^{\circ} \mathrm{C}\right.$ to $\left.+85^{\circ} \mathrm{C}\right)$.

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## SPECIFICATIONS

## DC SPECIFICATIONS

$V_{D D}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.0 \mathrm{~V}$; external reference, unless otherwise noted.
Table 1.

| Parameter | Temp | Test Level | AD9218BST-40/-65 |  |  | AD9218BST-80/-105 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max |  |
| RESOLUTION |  |  |  | 10 |  |  | 10 |  | Bits |
| ACCURACY <br> No Missing Codes ${ }^{1}$ <br> Offset Error ${ }^{2}$ <br> Gain Error ${ }^{2}$ <br> Differential Nonlinearity (DNL) <br> Integral Nonlinearity (INL) | Full <br> $25^{\circ} \mathrm{C}$ <br> $25^{\circ} \mathrm{C}$ <br> $25^{\circ} \mathrm{C}$ <br> Full <br> $25^{\circ} \mathrm{C}$ <br> Full | $\begin{array}{\|l} \hline \mathrm{VI} \\ \mathrm{I} \\ \mathrm{I} \\ \mathrm{I} \\ \mathrm{VI} \\ \mathrm{VI} \\ \mathrm{VI} \end{array}$ | $\begin{aligned} & -18 \\ & -2 \\ & -1 \\ & -1 /-1.6 \end{aligned}$ | uaranteed, <br> 2 <br> 3 <br> $\pm 0.3 / \pm 0.6$ <br> $\pm 0.8$ <br> $\pm 0.3 / \pm 1$ <br> $\pm 1$ | sted <br> 18 <br> 8 <br> 1/1.3 <br> 1/1.6 | $\begin{aligned} & -18 \\ & -2 \\ & -1 \\ & -1.35 /-2.7 \end{aligned}$ | $\begin{aligned} & \text { laranteed, no } \\ & 2 \\ & 3.5 \\ & \pm 0.5 / \pm 0.8 \\ & \pm 0.6 / \pm 0.9 \\ & \pm 0.75 / \pm 2 \\ & \pm 1 / \pm 2.3 \end{aligned}$ | 18 <br> 8 <br> 1.2/1.7 $+1.35 / 2.7$ | $\begin{aligned} & \text { LSB } \\ & \% \text { FS } \\ & \text { LSB } \\ & \text { LSB } \\ & \text { LSB } \\ & \text { LSB } \end{aligned}$ |
| TEMPERATURE DRIFT <br> Offset Error <br> Gain Error ${ }^{2}$ <br> Reference | Full <br> Full <br> Full | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ |  | $\begin{aligned} & 10 \\ & 80 \\ & 40 \\ & \hline \end{aligned}$ |  |  | $\begin{aligned} & 4 \\ & 100 \\ & 40 \end{aligned}$ |  | $\mathrm{ppm} /{ }^{\circ} \mathrm{C}$ <br> ppm $/{ }^{\circ} \mathrm{C}$ <br> ppm $/{ }^{\circ} \mathrm{C}$ |
| REFERENCE <br> Internal Reference Voltage ( $\mathrm{REF}_{\text {OUT }}$ ) Input Resistance ( $\mathrm{REF}_{1 \mathrm{~N}} \mathrm{~A}$, REF ${ }_{\text {IN }} B$ ) | $\begin{aligned} & 25^{\circ} \mathrm{C} \\ & \text { Full } \end{aligned}$ | I VI | $\begin{aligned} & 1.18 \\ & 9 \end{aligned}$ | $\begin{aligned} & 1.24 \\ & 11 \end{aligned}$ | 1.28 13 | $\begin{aligned} & 1.18 \\ & 9 \end{aligned}$ | $\begin{aligned} & 1.24 \\ & 11 \end{aligned}$ | $\begin{aligned} & 1.28 \\ & 13 \end{aligned}$ | V <br> k $\Omega$ |
| ANALOG INPUTS <br> Differential Input Voltage Range $\left(A_{A_{N}}, \overline{A_{\text {IN }}}\right)^{3}$ <br> Common-Mode Voltage ${ }^{3}$ Input Resistance Input Capacitance | Full <br> Full <br> Full <br> $25^{\circ} \mathrm{C}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{VI} \\ & \mathrm{~V} \end{aligned}$ | 8 | $\begin{aligned} & 1 \text { or } 2 \\ & V_{D} / 3 \\ & 10 \\ & 3 \end{aligned}$ | 14 | 8 | $\begin{aligned} & 1 \\ & V_{D} / 3 \\ & 10 \\ & 3 \end{aligned}$ | 14 | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{k} \Omega \\ & \mathrm{pF} \end{aligned}$ |
| POWER SUPPLY <br> $V_{D}$ <br> $V_{D D}$ <br> Supply Currents $\begin{aligned} & \mathrm{IV}\left(\mathrm{~V}_{\mathrm{D}}=3.0 \mathrm{~V}\right)^{4} \\ & \mathrm{IV}_{\mathrm{DD}}\left(\mathrm{~V}_{\mathrm{DD}}=3.0 \mathrm{~V}\right)^{4} \end{aligned}$ <br> Power Dissipation DC ${ }^{5}$ <br> IV $V_{D}$ Power-Down Current ${ }^{6}$ <br> Power Supply Rejection Ratio | Full <br> Full <br> Full <br> $25^{\circ} \mathrm{C}$ <br> Full <br> Full <br> $25^{\circ} \mathrm{C}$ | $\begin{array}{\|l} \mathrm{IV} \\ \mathrm{IV} \\ \mathrm{VI} \\ \mathrm{~V} \\ \mathrm{VI} \\ \mathrm{VI} \\ \mathrm{II} \end{array}$ | $\begin{aligned} & 2.7 \\ & 2.7 \end{aligned}$ | $\begin{aligned} & 3 \\ & 3 \\ & \\ & 108 / 117 \\ & 7 / 11 \\ & 325 / 350 \\ & 20 \\ & \pm 1 \end{aligned}$ | 3.6 <br> 3.6 <br> 113/130 <br> 340/390 | $\begin{aligned} & 2.7 \\ & 2.7 \end{aligned}$ | $\begin{aligned} & 3 \\ & 3 \\ & \\ & 172 / 183 \\ & 13 / 17 \\ & 515 / 550 \\ & 22 \\ & \pm 1 \end{aligned}$ | 3.6 3.6 <br> 175/188 <br> 525/565 | V <br> V <br> mA <br> mA <br> mW <br> mA <br> mV/V |

${ }^{1}$ No missing codes across industrial temperature range guaranteed for 40 MSPS, 65 MSPS, and 80 MSPS grades. No missing codes at room temperature guaranteed for 105 MSPS grade.
${ }^{2}$ Gain error and gain temperature coefficients are based on the ADC only (with a fixed 1.25 V external reference) 65 grade in 2 V p-p range, $40,80,105$ grades in 1 V p-p range.
${ }^{3}\left(\mathrm{~A}_{\mathrm{IN}_{\mathrm{N}}}-\overline{\mathrm{A}_{\mathbb{N}}}\right)= \pm 0.5 \mathrm{~V}$ in 1 V range (full scale), $\left(\mathrm{A}_{\mathbb{N}}-\overline{\mathrm{A}_{\mathbb{N}}}\right)= \pm 1 \mathrm{~V}$ in 2 V range (full scale). The analog inputs self-bias to $\mathrm{V}_{\mathrm{D}} / 3$. This common-mode voltage can be overdriven externally by a low impedance source by $\pm 300 \mathrm{mV}$ (differential drive, gain $=1$ ) or $\pm 150 \mathrm{mV}$ (differential drive, gain $=2$ ).
4 AC power dissipation measured with rated encode and a 10.3 MHz analog input @ $0.5 \mathrm{dBFS}, \mathrm{C}_{\text {LOAD }}=5 \mathrm{pF}$.
${ }^{5} D C$ power dissipation measured with rated encode and a dc analog input (outputs static, $\mathrm{IV}_{\mathrm{DD}}=0$ ).
${ }^{6}$ In power-down state, $I V_{D D}= \pm 10 \mu$ A typical (all grades).

## SPECIFICATIONS

## DIGITAL SPECIFICATIONS

$V_{D D}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.0 \mathrm{~V}$; external reference, unless otherwise noted.
Table 2.

| Parameter | Temp | Test <br> Level | AD9218BST-40/-65 |  |  | AD9218BST-80/-105 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max |  |
| DIGITAL INPUTS |  |  | $2 \quad V_{D} / 2$ |  |  | $2 \quad V_{D} / 2$ |  |  |  |
| Encode Input Common Mode | Full | V |  |  |  |  | V |  |
| Encode 1 Voltage | Full | VI |  |  |  |  | V |  |
| Encode 0 Voltage | Full | VI |  | 2.0 | 0.8 |  |  | 1.8 | 2.0 | 0.8 | V |
| Encode Input Resistance | Full | VI | 1.8 |  | 2.3 |  |  | 2.3 |  | $k \Omega$ |
| Logic 1 Voltage-S1, S2, DFS | Full | VI | 2 |  |  | 2 |  |  |  | V |
| Logic 0 Voltage-S1, S2, DFS | Full | VI |  |  | 0.8 |  | $\pm 0$ | 0.8 | V |
| Logic 1 Current-S1 | Full | VI | -50 | $\pm 0$ | 50 | -50 |  | 50 | $\mu \mathrm{A}$ |
| Logic 0 Current-S1 | Full | VI | -400 | -230 | -50 | $\begin{aligned} & -400 \\ & 50 \end{aligned}$ | -230 | -50 | $\mu \mathrm{A}$ |
| Logic 1 Current-S2 | Full | VI | 50 | 230 | 400 |  | 230 | 400 | $\mu \mathrm{A}$ |
| Logic 0 Current-S2 | Full | VI | -50 | $\pm 0$ | 50 | -50 | $\pm 0$ | 50 | $\mu \mathrm{A}$ |
| Logic 1 Current-DFS | Full | VI | 30 | 100 | 200 | 30 | 100 | 200 | $\mu \mathrm{A}$ |
| Logic 0 Current-DFS | Full | VI | -400 | -230 | -50 | -400 | -230 | -50 | $\mu \mathrm{A}$ |
| Input Capacitance-S1, S2, Encode Inputs | $25^{\circ} \mathrm{C}$ | V | 2 |  |  | 2 |  |  | pF |
| Input Capacitance DFS | $25^{\circ} \mathrm{C}$ | V | 4.5 |  |  | 4.5 |  |  | pF |
| DIGITAL OUTPUTS |  |  | 2.45 |  |  |  |  |  |  |
| Logic 1 Voltage | Full | VI |  |  |  | 2.45 |  |  | V |
| Logic 0 Voltage | Full | VI |  |  | 0.05 |  |  | 0.05 | V |
| Output Coding |  |  |  | Twos complement or offset binary |  |  | ment or | et binary |  |

## AC SPECIFICATIONS

$V_{D D}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.0 \mathrm{~V}$; external reference, unless otherwise noted.

Table 3.

| Parameter | Temp | Test <br> Level | AD9218BST-40/-65 |  |  | AD9218BST-80/-105 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max |  |
| DYNAMIC PERFORMANCE ${ }^{1}$ |  |  |  |  |  |  |  |  |  |
| Signal-to-Noise Ratio (SNR) |  |  |  |  |  |  |  |  |  |
| (Without Harmonics) |  |  |  |  |  |  |  |  |  |
| $\mathrm{f}_{\mathrm{IN}}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 58/55 | 59/57 |  | 57/53 | 58/55 |  | dB |
| $\mathrm{fiN}_{\text {N }}=$ Nyquist ${ }^{2}$ | $25^{\circ} \mathrm{C}$ | I | -/54 | 59/56 |  | 55/52 | 57/54 |  | dB |
| Signal-to-Noise and Distortion (SINAD) |  |  |  |  |  |  |  |  |  |
| (With Harmonics) |  |  |  |  |  |  |  |  |  |
| $\mathrm{f}_{\mathrm{N}}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 58/54 | 59/56 |  | 56/52 | 58/53 |  | dB |
| $\mathrm{f}_{\mathrm{IN}}=$ Nyquist $^{2}$ | $25^{\circ} \mathrm{C}$ | I | -/53 | 59/55 |  | 55/51 | 57/53 |  | $d B$ |
| Effective Number of Bits |  |  |  |  |  |  |  |  |  |
| $\mathrm{f}_{\mathrm{iN}}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 9.4/8.8 | 9.6/9.1 |  | 9.1/8.4 | 9.4/8.6 |  | Bits |
| $\mathrm{f}_{\mathrm{IN}}=$ Nyquist $^{2}$ | $25^{\circ} \mathrm{C}$ | I | -/8.6 | 9.6/8.9 |  | 9/8.3 | 9.3/8.6 |  | Bits |
| Second Harmonic Distortion |  |  |  |  |  |  |  |  |  |
| $\mathrm{f}_{\mathrm{N}}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 1 | -72/-66 | -89/-77 |  | -69/-60 | -771-68 |  | dBC |
| $\mathrm{f}_{\mathrm{IN}}=$ Nyquist $^{2}$ | $25^{\circ} \mathrm{C}$ | I | -\|-63 | -89/-72 |  | -65/-57 | -76/-66 |  | dBC |
| Third Harmonic Distortion | $25^{\circ} \mathrm{C}$ | 1 | -68/-62 | -79/-68 |  | -62-57 | -71-63 |  | dBc |

## SPECIFICATIONS

Table 3. (Continued)

| Parameter | Temp | Test Level | AD9218BST-40/-65 |  |  | AD9218BST-80/-105 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{f}_{\mathrm{IN}}=$ Nyquist $^{2}$ | $25^{\circ} \mathrm{C}$ | I | -\|-60 | -78/-64 |  | -63/-57 | -73/-69 |  | dBC |
| Spurious Free Dynamic Range (SFDR) $\begin{aligned} f_{\mathrm{f}_{\mathrm{N}}} & =10.3 \mathrm{MHz} \\ \mathrm{f}_{\mathrm{N}} & =\text { Nyquist }^{2} \end{aligned}$ | $\begin{aligned} & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \end{aligned}$ | $\begin{aligned} & \text { I } \\ & \text { I } \end{aligned}$ | $\left\lvert\, \begin{aligned} & -68 /-62 \\ & -\mid-60 \end{aligned}\right.$ | $\begin{aligned} & -79 /-67 \\ & -78 /-64 \end{aligned}$ |  | $\begin{aligned} & -62 \mid-57 \\ & -63 /-57 \end{aligned}$ | $\begin{aligned} & -69 /-62 \\ & -70 /-63 \end{aligned}$ |  | $\begin{aligned} & \mathrm{dBC} \\ & \mathrm{dBC} \end{aligned}$ |
| Two-Tone Intermodulation Distortion (IMD) $\mathrm{f}_{\mathrm{N} 1}=10 \mathrm{MHz}, \mathrm{f}_{\mathrm{N} 2}=11 \mathrm{MHz} \text { at }-7 \mathrm{dBFS}$ $\mathrm{f}_{\mathrm{N} 1}=30 \mathrm{MHz}, \mathrm{f}_{\mathbb{N} 2}=31 \mathrm{MHz} \text { at }-7 \mathrm{dBFS}$ <br> Analog Bandwidth, Full Power <br> Crosstalk | $\begin{aligned} & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ |  | $\begin{aligned} & -74 /-73 \\ & -73 /-73 \\ & 300 \\ & -75 \end{aligned}$ |  |  | $\begin{aligned} & -77 /-67 \\ & 300 \\ & -75 \end{aligned}$ |  | dBc <br> dBC <br> MHz <br> dBc |

${ }^{1}$ AC specifications based on an analog input voltage of -0.5 dBFS at 10.3 MHz , unless otherwise noted. AC specifications for $40,80,105$ grades are tested in 1 Vp -p range and driven differentially. AC specifications for 65 grade are tested in 2 V p-p range and driven differentially.
2 The 65,80 , and 105 grades are tested close to Nyquist for that grade: $31 \mathrm{MHz}, 39 \mathrm{MHz}$, and 51 MHz for the 65,80 , and 105 grades, respectively.

## SWITCHING SPECIFICATIONS

$V_{D D}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.0 \mathrm{~V}$; external reference, unless otherwise noted.

## Table 4.

| Parameter | Temp | Test Level | AD9218BST-40/-65 |  |  | AD9218BST-80/-105 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max |  |
| ENCODE INPUT PARAMETERS <br> Maximum Encode Rate <br> Minimum Encode Rate <br> Encode Pulse Width High ( $\mathrm{t}_{\mathrm{EH}}$ ) <br> Encode Pulse Width Low ( $\mathrm{t}_{\mathrm{EL}}$ ) <br> Aperture Delay ( $\mathrm{t}_{\mathrm{A}}$ ) <br> Aperture Uncertainty (Jitter) | Full <br> Full <br> Full <br> Full <br> $25^{\circ} \mathrm{C}$ <br> $25^{\circ} \mathrm{C}$ | $\begin{array}{\|l} \mathrm{VI} \\ \text { IV } \\ \text { IV } \\ \text { IV } \\ \mathrm{V} \\ \mathrm{~V} \end{array}$ | $\begin{aligned} & 40 / 65 \\ & 7 / 6 \\ & 7 / 6 \end{aligned}$ | $\begin{aligned} & 2 \\ & 3 \end{aligned}$ | 20/20 | $\begin{aligned} & 80 / 105 \\ & 5 / 3.8 \\ & 5 / 3.8 \end{aligned}$ | $\begin{aligned} & 2 \\ & 3 \end{aligned}$ | 20/20 | MSPS <br> MSPS <br> ns <br> ns <br> ns <br> ps rms |
| DIGITAL OUTPUT PARAMETERS <br> Output Valid Time (tv) ${ }^{1}$ <br> Output Propagation Delay (tpp) ${ }^{1}$ <br> Output Rise Time ( $\mathrm{t}_{\mathrm{R}}$ ) <br> Output Fall Time ( $\mathrm{t}_{\mathrm{F}}$ ) <br> Out-of-Range Recovery Time <br> Transient Response Time <br> Recovery Time from Power-Down Pipeline Delay | $\begin{aligned} & \text { Full } \\ & \text { Full } \\ & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \\ & 25^{\circ} \mathrm{C} \\ & \text { Full } \end{aligned}$ | $\begin{aligned} & \mathrm{VI} \\ & \mathrm{VI} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{IV} \end{aligned}$ | 2.5 | $\begin{aligned} & 4.5 \\ & 1 \\ & 1.2 \\ & 5 \\ & 5 \\ & 10 \\ & 5 \end{aligned}$ | 7 | 2.5 | $\begin{aligned} & 4.5 \\ & 1.0 \\ & 1.2 \\ & 5 \\ & 5 \\ & 10 \\ & 5 \end{aligned}$ | 6 |  |

${ }^{1} t_{V}$ and $t_{P D}$ are measured from the 1.5 level of the ENCODE input to the $50 \% / 50 \%$ levels of the digital outputs swing. The digital output load during test is not to exceed an ac load of 5 pF or a dc current of $\pm 40 \mu \mathrm{~A}$. Rise and fall times are measured from $10 \%$ to $90 \%$.

## SPECIFICATIONS

## TIMING DIAGRAMS



Figure 2. Normal Operation, Same Clock (S1 = 1, S2 = 0) Channel Timing


Figure 3. Normal Operation with Two Clock Sources (S1 = 1, S2 = 0) Channel Timing


Figure 4. Data Align with Two Clock Sources (S1 = 1, S2 = 1) Channel Timing

## ABSOLUTE MAXIMUM RATINGS

Table 5.

| Parameter | Rating |
| :--- | :--- |
| $\mathrm{V}_{\mathrm{D}}, \mathrm{V}_{\mathrm{DD}}$ | 4 V |
| Analog Inputs | -0.5 V to $\mathrm{V}_{\mathrm{D}}+0.5 \mathrm{~V}$ |
| Digital Inputs | -0.5 V to $\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$ |
| REF $_{\text {IN }}$ Inputs | -0.5 V to $\mathrm{V}_{\mathrm{D}}+0.5 \mathrm{~V}$ |
| Digital Output Current | 20 mA |
| Operating Temperature | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| Storage Temperature | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Maximum Junction Temperature | $150^{\circ} \mathrm{C}$ |
| Maximum Case Temperature | $150^{\circ} \mathrm{C}$ |
| $\theta_{\mathrm{A}}$ (measured on a 4-layer board with solid ground | $57^{\circ} \mathrm{C} / \mathrm{W}$ |
| plane) |  |

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## EXPLANATION OF TEST LEVELS

Table 6. Explanation of Test Levels

| Test <br> Level | Description |
| :--- | :--- |
| I. | $100 \%$ production tested. |
| II. | $100 \%$ production tested at $25^{\circ} \mathrm{C}$ and sample tested at specified <br> temperatures. |
| III. | Sample tested only. <br> IV. <br> Parameter is guaranteed by design and characterization testing. <br> V. |
| Parameter is a typical value only. |  |
| VI. | $100 \%$ production tested at $25^{\circ} \mathrm{C}$; guaranteed by design and <br> characterization testing for industrial temperature range. <br> $100 \%$ production tested at temperature extremes for military devices. |

Table 7. User Select Modes

| S1 | S2 | Power-Down and Data Alignment Settings |
| :--- | :--- | :--- |
| 0 | 0 | Power down both Channel A and Channel B. |
| 0 | 1 | Power down Channel B only. |
| 1 | 0 | Normal operation (data align disabled). |
| 1 | 1 | Data align enabled (data from both channels available on rising <br> edge of Clock A. Channel B data is delayed by a $1 / 2$ clock cycle.) |

## ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 5. Pin Configuration

Table 8. Pin Function Descriptions

| Pin Number | Mnemonic | Description |
| :---: | :---: | :---: |
| $\begin{aligned} & 1,12,16,27,29,32, \\ & 34,45 \end{aligned}$ | GND | Ground. |
| 2 | $\mathrm{A}_{\text {IN }} \mathrm{A}$ | Analog Input for Channel A. |
| 3 | $\overline{A_{1 N} \mathrm{~A}}$ | Analog Input for Channel A (Complementary). |
| 4 | DFS/GAIN | Data Format Select and Analog Input Gain Mode. Low = offset binary output available, 1 V p-p supported; high = twos complement output available, 1 V p-p supported; floating $=$ offset binary output available, 2 V p-p supported; set to $\mathrm{V}_{\text {REF }}=$ twos complement output available, 2 V p-p supported. |
| 5 | REF ${ }_{\text {IN }} A$ | Reference Voltage Input for Channel A. |
| 6 | REF ${ }_{\text {OUT }}$ | Internal Reference Voltage. |
| 7 | REF ${ }_{1 \times} B$ | Reference Voltage Input for Channel B. |
| 8 | S1 | User Select No. 1. See Table 7. |
| 9 | S2 | User Select No. 2. See Table 7. |
| 10 | $\overline{A_{\text {IN }} B}$ | Analog Input for Channel B (Complementary). |
| 11 | $\mathrm{A}_{\text {IN }} \mathrm{B}$ | Analog Input for Channel B. |
| 13, 30, 31, 48 | $V_{D}$ | Analog Supply (3 V). |
| 14 | $\mathrm{ENC}_{B}$ | Clock Input for Channel B. |
| 15, 28, 33, 46 | $V_{D D}$ | Digital Supply ( 2.5 V to 3.6 V ). |
| 17 to 26 | $D 9_{B}$ to $\mathrm{DO} 0_{B}$ | Digital Output for Channel $\mathrm{B}\left(\mathrm{D9}_{B}=\mathrm{MSB}\right)$. |
| 35 to 44 | $D 0_{\text {A }}$ to $\mathrm{D} 9_{\text {A }}$ | Digital Output for Channel $\mathrm{A}\left(\mathrm{D} 9_{\mathrm{A}}=\mathrm{MSB}\right)$. |
| 47 | $\mathrm{ENC}_{\mathrm{A}}$ | Clock Input for Channel A. |

## TERMINOLOGY

## Analog Bandwidth

The analog input frequency at which the spectral power of the fundamental frequency (as determined by the FFT analysis) is reduced by 3 dB .

## Aperture Delay

The delay between the $50 \%$ point of the rising edge of the ENCODE command and the instant at which the analog input is sampled.

## Aperture Uncertainty (Jitter)

The sample-to-sample variation in aperture delay.

## Crosstalk

Coupling onto one channel being driven by a low level signal $(-40 \mathrm{dBFS})$ when the adjacent interfering channel is driven by a full-scale signal.

## Differential Analog Input Resistance, Differential Analog Input Capacitance, Differential Analog Input Impedance

The real and complex impedances measured at each analog input port. The resistance is measured statically and the capacitance and differential input impedances are measured with a network analyzer.

## Differential Analog Input Voltage Range

The peak-to-peak differential voltage that must be applied to the converter to generate a full-scale response. Peak differential voltage is computed by observing the voltage on a single pin and subtracting the voltage from the other pin, which is 180 degrees out of phase. Peak-to-peak differential is computed by rotating the input phase 180 degrees and again taking the peak measurement. The difference is then computed between both peak measurements.

## Differential Nonlinearity

The deviation of any code width from an ideal 1 LSB step.

## Effective Number of Bits (ENOB)

The effective number of bits is calculated from the measured SNR based on the equation
$E N O B=\frac{S N R_{M E A S U R E D}-1.76 \mathrm{~dB}}{6.02}$

## ENCODE Pulse Width/Duty Cycle

Pulse width high is the minimum amount of time that the ENCODE pulse should be left in Logic 1 state to achieve rated performance; pulse width low is the minimum time ENCODE pulse should be left in low state. See timing implications of changing $\mathrm{t}_{\mathrm{ENCH}}$ in text. At a given clock rate, these specifications define an acceptable ENCODE duty cycle.

## Full-Scale Input Power

Expressed in dbm. Computed using the following equation:
Power $_{\text {Full }- \text { Scale }}=10 \log \left(\frac{\frac{V_{\text {Full }}-\text { Scale }^{2} r m s}{Z_{\text {INPTT }}}}{0.001}\right)$

## Gain Error

Gain error is the difference between the measured and the ideal full-scale input voltage range of the ADC.

## Harmonic Distortion, Second

The ratio of the rms signal amplitude to the rms value of the second harmonic component, reported in dBc.

## Harmonic Distortion, Third

The ratio of the rms signal amplitude to the rms value of the third harmonic component, reported in dBc.

## Integral Nonlinearity

The deviation of the transfer function from a reference line measured in fractions of 1 LSB using a "best straight line" determined by a least-square curve fit.

## Minimum Conversion Rate

The encode rate at which the SNR of the lowest analog signal frequency drops by no more than 3 dB below the guaranteed limit.

## Maximum Conversion Rate

The encode rate at which parametric testing is performed.

## Output Propagation Delay

The delay between the $50 \%$ level crossing of ENCODE A or ENCODE $B$ and the $50 \%$ level crossing of the respective channel's output data bit.

Noise (for Any Range Within the ADC)
$V_{\text {NOISE }}=\sqrt{Z \times 0.001 \times 10\left(\frac{F S_{d B m}-S N R_{d B c}-\text { Signal }_{d B F S}}{10}\right)}$
where:
$Z$ is the input impedance.
FS is the full scale of the device for the frequency in question. SNR is the value for the particular input level.
Signal is the signal level within the ADC reported in dB below full scale. This value includes both thermal and quantization noise.

## Power Supply Rejection Ratio

The ratio of a change in input offset voltage to a change in power supply voltage.

## TERMINOLOGY

## Signal-to-Noise and Distortion (SINAD)

The ratio of the rms signal amplitude (set 1 dB below full scale) to the rms value of the sum of all other spectral components, including harmonics but excluding dc.

## Signal-to-Noise Ratio (without Harmonics)

The ratio of the rms signal amplitude (set at 1 dB below full scale) to the rms value of the sum of all other spectral components, excluding the first five harmonics and dc.

## Spurious-Free Dynamic Range (SFDR)

The ratio of the rms signal amplitude to the rms value of the peak spurious spectral component. The peak spurious component may or may not be a harmonic. Reported in dBc (that is, degrades as signal level is lowered) or dBFS (always related back to converter full scale).

## Two-Tone Intermodulation Distortion Rejection

The ratio of the rms value of either input tone to the rms value of the worst third-order intermodulation product; reported in dBc.

## Two-Tone SFDR

The ratio of the rms value of either input tone to the rms value of the peak spurious component. The peak spurious component may
or may not be an IMD product. Reported in dBc (that is, degrades as signal level is lowered) or in dBFS (always related back to converter full scale).

## Worst Other Spur

The ratio of the rms signal amplitude to the rms value of the worst spurious component (excluding the second and third harmonics) reported in dBc.

## Transient Response Time

Transient response is defined as the time it takes for the ADC to reacquire the analog input after a transient from $10 \%$ above negative full scale to $10 \%$ below positive full scale.

## Out-of-Range Recovery Time

Out-of-range recovery time is the time it takes for the ADC to reacquire the analog input after a transient from $10 \%$ above positive full scale to $10 \%$ above negative full scale or from $10 \%$ below negative full scale to $10 \%$ below positive full scale.

## EQUIVALENT CIRCUITS



Figure 6. Analog Input Stage


Figure 7. Encode Inputs


Figure 8. Reference Output Stage


Figure 9. Digital Output Stage


Figure 10. Reference Inputs


Figure 11. S2 Input


Figure 12. S1 Input


Figure 13. DFS/Gain Input

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 14. FFT: $\mathrm{FS}=105 \mathrm{MSPS}, A_{I N}=50.1 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, 1 V p-p Input Range


Figure 15. FFT: $\mathrm{FS}=80 \mathrm{MSPS}, A_{I N}=39 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, $1 \mathrm{Vp-p}$ Input Range


Figure 16. FFT: $F S=65 \mathrm{MSPS}, A_{I N}=30.3 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, 2 V p-p Input Range


Figure 17. FFT: FS $=40 \mathrm{MSPS}, A_{/ N}=19.75 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, 1 V p-p Input Range


Figure 18. FFT: FS $=105 \mathrm{MSPS}, A_{I N}=70 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, 1 V p-p Input Range


Figure 19. FFT: FS $=65 \mathrm{MSPS}, A_{I N}=15 \mathrm{MHz} @-0.5 \mathrm{dBFS}$; with AD8138 Driving ADC Inputs, 1 V p-p Input Range

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 20. FFT: FS $=31 \mathrm{MSPS}, A_{I N}=8 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, $1 \mathrm{Vp}-\mathrm{p}$ Input Range


Figure 21. Harmonic Distortion (Second and Third) and SFDR vs. AIN Frequency (1 Vp-p, FS = 105 MSPS)


Figure 22. Harmonic Distortion (Second and Third) and SFDR vs. $A_{I N}$ Frequency (1 Vp-p, FS = 80 MSPS)


Figure 23. FFT: FS $=31 \mathrm{MSPS}, A_{I N}=8 \mathrm{MHz} @-0.5 \mathrm{dBFS}$, Differential, with AD8138 Driving ADC Inputs,1 V p-p Input Range


Figure 24. Two-Tone Intermodulation Distortion ( 30.1 MHz and 31.1 MHz ; 1 V $p-p, F S=105$ MSPS)


Figure 25. Two-Tone Intermodulation Distortion (29.3 MHz and 30.3 MHz ; 1 V $p-p, F S=80$ MSPS $)$

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 26. Harmonic Distortion (Second and Third) and SFDR vs. AIN Frequency (FS = 65 MSPS)


Figure 27. Harmonic Distortion (Second and Third) and SFDR vs. $A_{I N}$ Frequency (1 Vp-p, FS = 40 MSPS)


Figure 28. SINAD and SFDR vs. Encode Rate ( $A_{I N}=10.3 \mathrm{MHz}, 105 \mathrm{MSPS}$ Grade, $A_{I N}=-0.5 \mathrm{dBFS}$ Differential, 1 V p-p Analog Input Range)


Figure 29. Two-Tone Intermodulation Distortion ( $28 \mathrm{MHz}, 29 \mathrm{MHz}$; 1 Vp -p, FS $=65$ MSPS)


Figure 30. Two-Tone Intermodulation Distortion (10 MHz, 11 MHz ; 1 Vp -p, FS $=40$ MSPS)


Figure 31. SINAD and SFDR vs. Encode Rate ( $A_{I N}=10.3 \mathrm{MHz}$, 65 MSPS Grade) $A_{I N}=-0.5 \mathrm{dBFS}$ Differential, 1 V -p Analog Input Range

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 32. SINAD and SFDR vs. Encode Pulse Width High, $A_{I N}=-0.5 d B F S$ Single-Ended, 1 Vp-p Analog Input Range 105 MSPS


Figure 33. $I V_{D}$ and $I V_{D D}$ vs. Encode Rate ( $A_{I N}=10.3 \mathrm{MHz}, @-0.5 \mathrm{dBFS}$ ), -65 MSPS/-105 MSPS Grade CI $=5 \mathrm{pF}$


Figure 34. $V_{R E F}$ Output Voltage vs. Temperature ( $\left.L_{\text {LOAD }}=300 \mu \mathrm{~A}\right)$


Figure 35. SINAD and SFDR vs. Encode Pulse Width High, $A_{I N}=-0.5 \mathrm{dBFS}$ Single-Ended, 1 V p-p Analog Input Range 65 MSPS


Figure 36. Gain Error vs. Temperature, $A_{I N}=10.3$ MHz, $\mathbf{- 6 5}$ MSPS Grade, -105 MSPS Grade, 1 V p-p


Figure 37. SNR, SINAD, SFDR vs. Temperature, $A_{I N}=10.3 \mathrm{MHz},-65 \mathrm{MSPS}$ Grade, -105 MSPS Grade, 1 V p-p

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 38. V REF vS. I LOAD


Figure 39. Typical INL Plot, $10.3 \mathrm{MHz} A_{I N} @ 80$ MSPS


Figure 40. SFDR vs. $A_{I N}$ Input Level, 10.3 MHz $A_{I N} @ 80$ MSPS


Figure 41. Typical DNL Plot, 10.3 MHz $A_{/ N} @ 80$ MSPS

## THEORY OF OPERATION

The AD9218 ADC architecture is a bit-per-stage pipeline-type converter utilizing switch capacitor techniques. These stages determine the 7 MSBs and drive a 3-bit flash. Each stage provides sufficient overlap and error correction, allowing optimization of comparator accuracy. The input buffers are differential, and both sets of inputs are internally biased. This allows the most flexible use of ac-coupled or dc-coupled and differential or single-ended input modes. The output staging block aligns the data, carries out the error correction, and feeds the data to output buffers. The set of output buffers are powered from a separate supply, allowing adjustment of the output voltage swing. There is no discernible difference in performance between the two channels.

## USING THE AD9218 ENCODE INPUT

Any high speed ADC is extremely sensitive to the quality of the sampling clock provided by the user. A track-and-hold circuit is essentially a mixer. Any noise, distortion, or timing jitter on the clock is combined with the desired signal at the analog-to-digital output. For that reason, considerable care has been taken in the design of the ENCODE input of the AD9218, and the user is advised to give commensurate thought to the clock source. The ENCODE input is fully TTL/CMOS compatible.

## DIGITAL OUTPUTS

The digital outputs are TTL/CMOS compatible for lower power consumption. During power-down, the output buffers transition to a high impedance state. A data format selection option supports either twos complement (set high) or offset binary output (set low) formats.

## ANALOG INPUT

The analog input to the AD9218 is a differential buffer. For best dynamic performance, impedance at $\mathrm{A}_{\text {IN }}$ and $\overline{\mathrm{A}_{I N}}$ should match. Special care was taken in the design of the analog input section of the AD9218 to prevent damage and data corruption when the input is overdriven. The nominal input range is $1.024 \mathrm{~V} p-\mathrm{p}$. Optimum performance is obtained when the part is driven differentially where common-mode noise is minimized and even-order harmonics are reduced. Figure 42 shows an example of the AD9218 being driven differentially via a wideband RF transformer for ac-coupled applications. As shown in Figure 43, applications that require dc-coupled differential drives can be accommodated using the AD8138 differential output op amp.


Figure 42. Using a Wideband Transformer to Drive the AD9218


Figure 43. Using the AD8138 to Drive the AD9218

## VOLTAGE REFERENCE

A stable and accurate 1.25 V voltage reference is built into the AD9218 (VREF OUT). Typically, the internal reference is used by strapping Pin $5\left(\right.$ REF $\left._{\text {IN }} \mathrm{A}\right)$ and Pin $7\left(\right.$ REF $\left._{\text {IN }} \mathrm{B}\right)$ to Pin 6 (REF $\left.{ }_{\text {out }}\right)$. The input range for each channel can be adjusted independently by varying the reference voltage inputs applied to the AD9218. No appreciable degradation in performance occurs when the reference is adjusted $\pm 5 \%$. The full-scale range of the ADC tracks reference voltage, which changes linearly (a $5 \%$ change in VREF results in a $5 \%$ change in full scale).

## TIMING

The AD9218 provides latched data outputs, with five pipeline delays. Data outputs are available one propagation delay (tpp) after the rising edge of the encode command (see Figure 2 through Figure 4). The length of the output data lines and loads placed on them should be minimized to reduce transients within the AD9218. These transients can detract from the dynamic performance of the converter.

The minimum guaranteed conversion rate is 20 MSPS. At clock rates below 20 MSPS, dynamic performance degrades.

## USER SELECT OPTIONS

Two pins are available for a combination of operational modes, enabling the user to power down both channels, excluding the reference, or just the $B$ channel. Both modes place the output buffers in a high impedance state. Recovery from a power-down state is accomplished in 10 clock cycles following power-on.

The other option allows the user to skew the B channel output data by one-half a clock cycle. In other words, if two clocks are fed to the AD9218 and are 180 degrees out of phase, enabling the data align allows Channel B output data to be available at the rising edge of Clock A. If the same encode clock is provided to both channels and the data align pin is enabled, output data from Channel $B$ is 180 degrees out of phase with respect to Channel A. If the same encode clock is provided to both channels and the data align pin is disabled, both outputs are delivered on the same rising edge of the clock.

## THEORY OF OPERATION

## APPLICATION INFORMATION

The wide analog bandwidth of the AD9218 makes it very attractive for a variety of high performance receiver and encoder applications. Figure 44 shows the dual ADC in a typical low cost I and Q demodulator implementation for cable, satellite, or wireless LAN modem receivers. The excellent dynamic performance of the ADC at higher analog input frequencies and encode rates lets users employ direct IF sampling techniques. IF sampling eliminates or simplifies analog mixer and filter stages to reduce total system cost and power.


Figure 44. Typical I/Q Demodulation Scheme

## AD9218/AD9288 CUSTOMER PCB BOM

Table 9. Bill of Materials

| No. | Qty | Reference Designator | Device | Package | Value | Comments |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 29 | C1, C3 to C15, C20, C21, C24, C25, C27, C30 to C35, C39 to C42 | Capacitor | 0603 | $0.1 \mu \mathrm{~F}$ |  |
| 2 | 2 | C2, C36 | Capacitor | 0603 | 15 pF | 8138 out |
| 3 | 7 | C16-C19, C26, C37, C38 | Capacitor | TAJD | $10 \mu \mathrm{~F}$ |  |
| 4 | 28 | E1, E2, E3, E4, E12 to E30, E34 to E38 | W-HOLE | W-HOLE |  |  |
| 5 | 4 | H1, H2, H3, H4 | MTHOLE | MTHOLE |  |  |
| 6 | 5 | J1, J2, J3, J4, J5 | SMA | SMA |  | J2, J3 not placed |
| 7 | 3 | P1, P4, P11 | 4-lead power connector | Post | Z5.531.3425.0 | Wieland |
| 8 | 3 | P1, P4, P11 | 4-lead power connector | Detachable connector | 25.602.5453.0 | Wieland |
| 9 | 1 | P2, P3 ${ }^{1}$ | 80-lead rt. angle male |  | TSW-140-08-L-D-RA | Samtec |
| 10 | 4 | R1, R2, R32, R34 | Resistor | 0603 | $36 \Omega$ | R1, R2, R32, R34, not placed |
| 11 | 9 | R3, R7, R11, R14, R22, R23, R24, R30, R51 | Resistor | 0603 | $50 \Omega$ | R11, R22, R23, R24, R30, R51 not placed |
| 12 | 17 | R4, R5, R8, R9, R10, R12, R13, R20, R33, R35, R36, R37, R40, R42, R43, R50, R53 | Resistor | 0603 | $0 \Omega$ | R43, R50 not placed |
| 13 | 2 | R6, R38 | Resistor | 0603 | $25 \Omega$ | R6, R38 not placed |
| 14 | 6 | R15, R16, R18, R26, R29, R31 | Resistor | 0603 | $500 \Omega$ | R16, R29 not placed |
| 15 | 2 | R17, R25 | Resistor | 0603 | $525 \Omega$ |  |
| 16 | 2 | R19, R27 | Resistor | 0603 | $4 \mathrm{k} \Omega$ |  |
| 17 | 12 | R21, R28, R39, R41, R44, R46 to R49, R52, R54, R55 | Resistor | 0603 | $1 \mathrm{k} \Omega$ |  |
| 18 | 2 | T1, T2 | Transformer | ADT1-1WT |  | Minicircuits |
| 19 | 1 | U1 | AD9288 or AD9218 ${ }^{2}$ | LQFP48 |  |  |
| 20 | 2 | U2, U3 | 74LCX821 |  |  |  |
| 21 | 2 | U5, U6 | SN74VCX86 |  |  |  |
| 22 | 4 | U7, U8, U9, U10 | Resistor array | CTS | $47 \Omega$ | 768203470G |
| 23 | 2 | U11, U12 | AD8138 op amp ${ }^{3}$ |  |  |  |

[^0]
## EVALUATION BOARD

The AD9218/AD9288 customer evaluation board offers an easy way to test the AD9218 or the AD9288. The compatible pinout of the two parts facilitates the use of one PCB for testing either part. The PCB requires power supplies, a clock source, and a filtered analog source for most ADC testing required.

## POWER CONNECTOR

Power is supplied to the board via a detachable 12-lead power strip. The minimum 3 V supplies required to run the board are $\mathrm{V}_{\mathrm{D}}$, $V_{D L}$, and $V_{D D}$. To allow the use of the optional amplifier path, $\pm 5 \mathrm{~V}$ supplies are required.

## ANALOG INPUTS

Each channel has an independent analog path that uses a wideband transformer to drive the ADC differentially from a single-ended sine source at the input SMAs. The transformer paths can be bypassed to allow the use of a dc-coupled path using two AD8138 op amps with a simple board modification. The analog input should be band-pass filtered to remove any harmonics in the input signal and to minimize aliasing.

## VOLTAGE REFERENCE

The AD9218 has an internal 1.25 V voltage reference; an external reference for each channel can be employed instead by connecting two external voltage references at the power connector and setting jumpers at E18 and E19. The evaluation board is shipped configured for internal reference mode.

## CLOCKING

Each channel can be clocked by a common clock input at SMA inputs ENCODE A and ENCODE B. The channels can also be clocked independently by a simple board modification. The clock input should be a low jitter sine source for maximum performance.

## DATA OUTPUTS

The data outputs are latched on board by two 10-bit latches and drive an 8 -lead connector, which is compatible with the dual-channel FIFO board that is available from Analog Devices, Inc. This board, together with ADC analyzer software, can greatly simplify ADC testing.

## DATA FORMAT/GAIN

The DFS/GAIN pin can be biased for desired operation at the DFS jumper located at the S1, S2 jumpers.

## TIMING

Timing on each channel can be controlled, if needed, on the PCB. Clock signals at the latches or the data ready signals that go to the output 80 -lead connector can be inverted if required. Jumpers also allow for biasing of Pin S1 and Pin S2 for power-down and timing alignment control.

## TROUBLESHOOTING

If the board does not seem to be working correctly, try the following:

- Verify power at the IC pins.
- Check that all jumpers are in the correct position for the desired mode of operation.
- Verify that $\mathrm{V}_{\text {REF }}$ is at 1.23 V .
- Try running encode clock and analog inputs at low speeds (20 MSPS/1 MHz) and monitor the LCX821 outputs, DAC outputs, and ADC outputs for toggling.

The AD9218 evaluation board is provided as a design example for customers of Analog Devices. Analog Devices makes no warranties, express, statutory, or implied, regarding merchantability or fitness for a particular purpose.

## EVALUATION BOARD



Figure 45. PCB Schematic

## EVALUATION BOARD



Figure 46. PCB Schematic (Continued)

## EVALUATION BOARD



Figure 47. Top Silkscreen


Figure 48. Top Routing

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Figure 49. Ground Plane


Figure 50. Split Power Plane


Figure 51. Bottom Routing
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Figure 52. Bottom Silkscreen

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-026-BBC

Figure 53. 48-Lead Low Profile Quad Flat Package [LQFP]
(ST-48)
Dimensions shown in millimeters
Updated: June 29, 2023

## ORDERING GUIDE

| Model ${ }^{1}$ | Temperature Range | Package Description | Packing Quantity | Package Option |
| :---: | :---: | :---: | :---: | :---: |
| AD9218BSTZ-105 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7mm) |  | ST-48 |
| AD9218BSTZ-40 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7 mm ) |  | ST-48 |
| AD9218BSTZ-65 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7 mm ) |  | ST-48 |
| AD9218BSTZ-80 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7 mm ) |  | ST-48 |
| AD9218BSTZ-RL105 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7 mm ) | Reel, 2000 | ST-48 |
| AD9218BSTZ-RL40 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7mm) | Reel, 2000 | ST-48 |
| AD9218BSTZ-RL65 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7mm) | Reel, 2000 | ST-48 |
| AD9218BSTZ-RL80 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48-Lead LQFP (7mm x 7mm) | Reel, 2000 | ST-48 |

[^1]
[^0]:    1 P2, P3 are implemented as one physical 80-lead connector SAMTEC TSW-140-08-L-D-RA.
    2 AD9288/PCB populated with AD9288-100, AD9218-65/PCB populated with AD9218-65, AD9218-105/PCB populated with AD9218-105.
    3 To use optional amp place R22, R23, R30, R24, R16, R29, remove R4, R36.

[^1]:    1 Z = RoHS Compliant Part.

